

Search Notes**Application/Control No.**

10/535,480

Examiner

EDMUND H. LEE

**Applicant(s)/Patent under
Reexamination**

ENO ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
264	250,238	7/10/2008	EHL
	248,247		
	328.1		
264/493,494			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
264/250,238,248,247,328.1,493,494	7/10/2008	EHL
east		
inventor		
updated searches		